

AMENDMENT TO THE CLAIMS

1. (Currently amended) A method of manufacturing a ceramic thick-film printed circuit board, comprising the steps of:

forming a layer comprising a resin having a thickness ranging from 0.15 to 2 μm on a substrate;

forming a printed pattern on said layer ~~a substrate~~; and

firing the printed pattern positioned on said layer[[,]]

~~wherein a layer comprising a resin having a thickness ranging from 0.15 to 2 μm is formed on the surface of the substrate prior to the printed pattern forming step.~~

2. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 1, wherein the thickness of the layer is controlled by a mixing ratio of resins having a same chemical structure and different molecular weights.

3. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 1, wherein a temperature increasing rate ranges from 80 to 120 $^{\circ}\text{C}/\text{min}$ in the firing step.

4. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 3, wherein the temperature increasing rate is adjusted according to a molecular weight of the resin.

5. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 1, wherein a fired film has a thickness ranging from 5 to 22 μm .

6. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 5, wherein the thickness of the fired film is adjusted according to a molecular weight of a binder resin contained in a printing paste.
7. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 1, wherein a printing paste having a solvent content ranging from 8 to 25 wt% is used in the printed pattern forming step.
8. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 7, wherein the solvent content of the printing paste is adjusted according to a molecular weight of the resin.
9. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 1, wherein the resin layer has an average surface roughness R_a ranging from 0.15 to 0.5 μm or a maximum surface roughness R_{max} ranging from 1.5 to 5 μm according to a measuring method of Japanese Industrial Standards (JIS) B0601.
10. (Original) The method of manufacturing a ceramic thick-film printed circuit board of claim 1, wherein one of the resin layer and an emulsion of a screen mask used in the printed pattern forming step has an average surface roughness R_a ranging from 0.25 to 0.5 μm or a maximum surface roughness R_{max} ranging from 2 to 5 μm .